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RADEWEEKE No.: 63979-028

PATENT

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Application of : Customer Number: 20277

Takashi NISHIKAWA, et al. : Confirmation Number: 2411

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Serial No.: 10/616,917 : Group Art Unit: 2811

Filed: July 11, 2003 : Examiner: To be Assigned

For: A SEMICONDUCTOR DEVICE AND A FABRICATION METHOD THEREOF

INFORMATION DISCLOSURE STATEMENT

Mail Stop IDS Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

Dear Sir:

In accordance with the provisions of 37 C.F.R. 1.56, 1.97 and 1.98, the attention of the Patent and Trademark Office is hereby directed to the references listed on the attached form PTO-1449. It is respectfully requested that the references be expressly considered during the prosecution of this application, and that the references be made of record therein and appear among the "References Cited" on any patent to issue therefrom.

This Information Disclosure Statement is being filed within three months of the U.S. filing date OR before the mailing date of a first Office Action on the merits. No certification or fee is required.

Each non-English language reference was first cited in a corresponding foreign application search report or office action and its relevance discussed therein. A copy of the foreign search report or office action is attached for the Examiner's information.

10/616,917

Please charge any shortage in fees due in connection with the filing of this paper, including extension of time fees, to Deposit Account 500417 and please credit any excess fees to such deposit account.

Respectfully submitted,

MCDERMOTT, WILL & EMERY

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Date: October 9, 2003

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INFORMATION DISCLOSURE CITATION IN AN					ATTY. DOCKET NO. 63979-028		IAL NO. 6 16,917		
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AFFLICATION					APPLICANT Takashi NISHIKAWA, et al.				
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& TRAUE				U.S. PATEN	T DOCUMENTS				
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1 Applicant's unique citation designation number (optional). 2 Applicant is to place a check mark here if English language Translation is attached.